

Attorney's Docket No.: 10449-032001 / P1S2000220US

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Koji Hayashi et al.

Art Unit : 2653

Serial No.: 09/748,506

Examiner: Chu, K.

Filed Title

: December 26, 2000

: CONTROLLER OF DATA RECORDER

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Commissioner for Patents

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INFORMATION DISCLOSURE STATEMENT

Applicants submit the references listed on the attached form PTO-1449.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,

Date: June 15, 2004

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Substitute Form PTO-1449 (Madified)

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 10449-032001

Application No. 09/748,506

Information Disclosure Statement by Applicant

Applicant Koji Hayashi et al.

Filing Date

Group Art Unit 2653

(Use several sheets if necessary)

December 26, 2000

U.S. Patent Documents Examiner Desig. Document Publication Filing Date Initial ID Number Date Patentee Class Subclass If Appropriate AA5,010,534 04/23/91 Enari et al. AB5,477,516 12/19/95 Takezawa AC RECEIVED AD JUN 2 1 2004 ΑE AF Technology Center 2600 AG AΗ ΑI AJ AK

| Foreign Patent Documents or Published Foreign Patent Applications | | | | | | | | |
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| Initial | ID | Number | Date | Patent Office | Class | Subclass | Yes | No |
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| Other Documents (include Author, Title, Date, and Place of Publication) | | | | |
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